



Burn In Test

The Burn-In test will expose the DUT (device under test) to harsh conditions: 150°C; relative humidity (RH): 85 rh; current rating: 1A continuous for 1000 hrs. In order to withstand conditions like that, C.C.P. modifies the plating material and core material. C.C.P. splits the socket into two parts: The standard part and the machining part. The standard part is manufactured by insert molding and holds the machining part which is customized according to the customers' IC design and made by CNC. The pins for the burn-in solution use a special material (WJ3) that shows an exceptional hardness and is able to withstand the demanding conditions posed by the Burn-In test.

Design Concept



Burn in Socket	Specification
IC Size	<15x15 mm²
Min. Pitch	0.3
Body Material	PES (Black)
Housing Material	Ultem2300
Operating Temperature	-55°C~180°C

Pogo Type Burn-in Socket

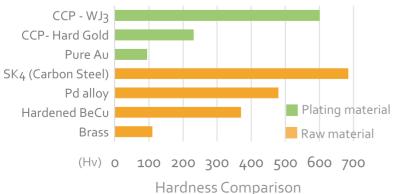
C.C.P. splits the socket into a standard part and a machining part. The standard part is processed by insert molding while the machining part is manufactured by CNC according to IC's size. This shortens the development time and reduces the mold tooling cost. C.C.P. can customize the sockets according to your needs.





Customized part Standard Part Manufactured according to IC size

Plating / Raw Material



Commonly used in burn in test solution, WJ3 is a special plating material developed by C.C.P. and usually plated on the DUT side plunger. Besides high hardness, WJ3 is able to perform steadily in severe testing environments that reach 150°C for 1000 hours possibly even for 3000 hours.

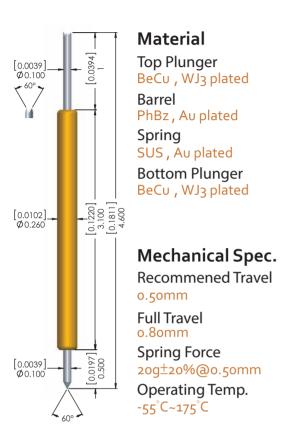


C.C.P. Contact Probes Co., Ltd.

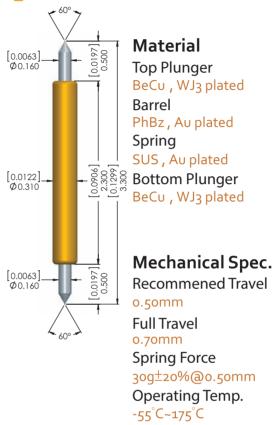
Probe Specifications

Unit:mm; []:in

WE1-026EF31-01A0



WE1-031BB23-01A0



Electrical Spec.

Current Rating 1A continuous Contact Resistance $<175m\Omega(AVG)$ Characteristic Impedance 57Ω Insertion Loss -1dB>20GHz Return Loss -20dB@8.38GHz Time Delay 23.4 psec Loop Inductance 1.34 nH Capacitance 0.41pF

Electrical Spec.



Current Rating 1.5A continuous Contact Resistance <175m $\Omega(AVG)$ Characteristic Impedance 40.8Ω Insertion Loss -1dB>20 GHz Return Loss -2odB@ 5.3 GHz Time Delay 15.9 psec Loop Inductance o.65 nH Capacitance 0.39 pF

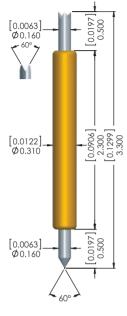




Probe Specifications

Unit:mm; []:in

WE1-031BF23-01A0



Material

Top Plunger BeCu, WJ₃ plated Barrel PhBz, Au plated Spring SUS, Au plated **Bottom Plunger** BeCu, WJ₃ plated

Mechanical Spec.

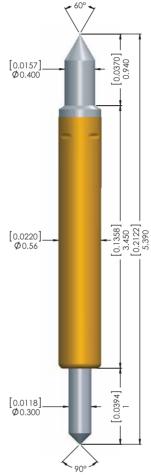
Recommened Travel

o.50mm

Full Travel o.70mm Spring Force 30g±20%@0.50mm

Operating Temp. -55°C~175°C

WE3-056BE34-02A0



Material

Top Plunger BeCu, WJ₃ plated Barrel Brass, Au plated Spring SUS, Au plated **Bottom Plunger** BeCu, WJ3 plated

Mechanical Spec.

Recommened Travel 0.67mm

Full Travel o.gomm

Spring Force 35g±20%@0.67mm

Operating Temp.

-55°C~175°C

Electrical Spec.

Capacitance 0.51 pF



Current Rating 1.5A continuous Contact Resistance $<175m\Omega(AVG)$ Characteristic Impedance 33.72Ω Insertion Loss -1dB@12.51GHz Return Loss -2odB@2.49GHz Time Delay 17.2 psec Loop Inductance 0.58 nH



Capacitance 0.92 pF



Current Rating 5A continuous Contact Resistance <75m $\Omega(AVG)$ Characteristic Impedance 32.1Ω Insertion Loss -1dB@7GHz Return Loss -20dB@1.19 GHz Time Delay 29.5 psec Loop Inductance 0.95nH

B.C.E. s.r.l.

